AMENDED CLAIMS

[Received by the International Bureau on 27 October 2004 (27.10.04): original claims 1-11 unchanged, new claims 12-17 added (2 pages)]

12. A deflection apparatus, comprising:

a cathode ray tube having a faceplate panel with a short axis and a long axis, the faceplate panel having a display screen on the inside of the panel and the panel extending back to a funnel which houses an electron gun system within an integral neck for producing co-planar beams, the electron gun system being arranged in a linear array which is parallel to a short axis of the screen;

a horizontal deflection coil for generating a horizontal deflection field having a substantially barrel shaped field non-uniformity for scanning the beams in the direction of the long axis and a vertical deflection coil for generating a vertical deflection field having a substantially pincushioned shaped field non-uniformity for scanning the beams in the direction of the short axis, the field non-uniformity of at least one of said deflection fields being selected to provide a beam spot correction instead of providing a further misconvergence error correction; and

a third deflection coil for generating a third deflection field having a field non-uniformity selected to correct at least a portion of the misconvergence error left uncorrected by said one deflection field.

- 13. The deflection apparatus according to claim 12 wherein said third deflection coil generates a quadrupolar magnetic field.
- 14. The deflection apparatus according to claim 12, further comprising a fourth deflection coil, wherein said third and fourth deflection coils are arranged approximately 90 degrees from each other and positioned

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approximately at the dynamic astigmatism correction point of the electron gun system.

- 15. The deflection apparatus according to claim 12, wherein said third deflection coil is dynamically controlled.
- 16. The deflection apparatus according to claim 12, wherein said third deflection coil is driven at the horizontal deflection rate.
- 17. The deflection apparatus according to claim 12, wherein the misconvergence error is an overconvergence outer ones of the electron beams.